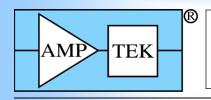


Detector Response

AMPTEK, INC.

14 Deangelo Drive, Bedford, MA 01730 Ph: +1 781 275 2242 Fax: +1 781 275 3470 sales@amptek.com www.amptek.com

XRF Overview 1

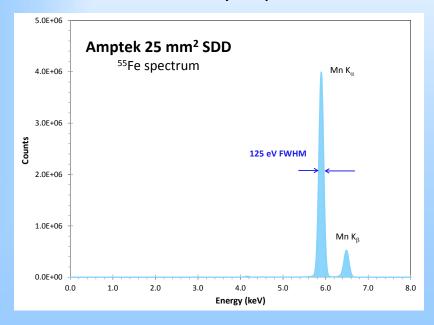


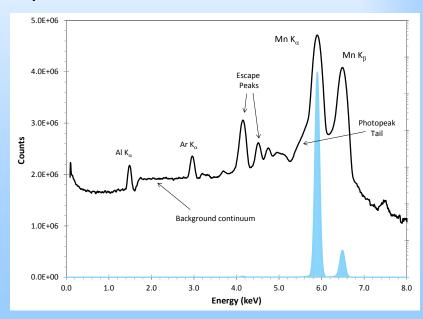
Detector

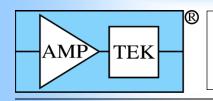
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Detector response function

- Linear plot (left) shows main photopeaks
- Log plot (right) shows many additional features
 - Some (e.g. escape peaks, some continuum) due to physics
 - Some (e.g. Al and Ar K_{α} lines, tail) from detector or setup
 - Details very important for trace analysis



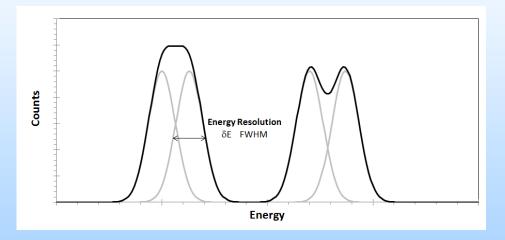




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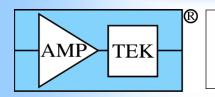
What is the "resolution"?

- Resolution defined as the full-width at half maximum (FWHM) of a peak
- If two peaks are separated by more than FWHM, there is a valley between them and we say they are resolved.



What is the peak shape?

- Theoretical limits give a Gaussian (FWHM= 2.35σ)
 - Real detectors always deviate at least a little



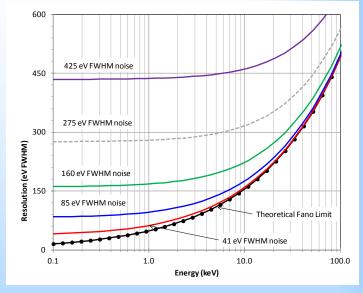
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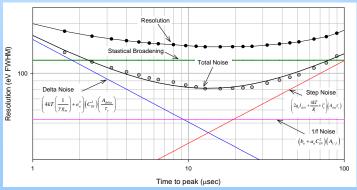
What contributes to photopeak shape & FWHM?

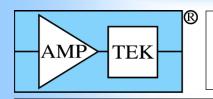
- Statistical fluctuation in charge
 - Depends only on the energy
 - A theoretical limit and cannot be avoided
 - Truly Gaussian
- Intrinsic electronic noise
 - Independent of energy
 - Depends on detector, temperature, T_{peak}
 - Can be minimized but not eliminated
 - Truly Gaussian

$$\delta E = \sqrt{F\Box E + ENC^{2}}$$

$$ENC^{2} = C_{IN} \left(\frac{A_{1}}{T_{peak}}\right) + N_{1/f} + \sqrt{I_{leak}} \left(A_{2}T_{peak}\right)$$



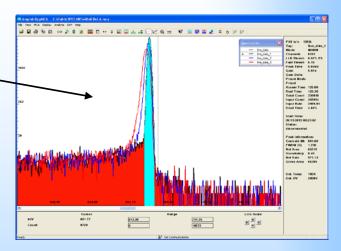


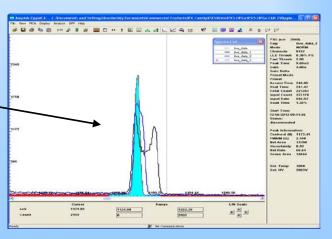


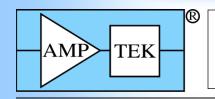
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What else contributes to photopeak shape & FWHM?

- Charge trapping
 - Gives a tail to lower energies
 - Always present, sometimes important
 - Can be low energy, high energy, etc
- Ballistic deficit
 - Gives a tail to lower energies
 - Occurs when T_{flat} < T_{collection}
- Interference noise
 - Photopeak shape can be surprising
 - From ground loops, EMI, microphonics
 - Can be eliminated
- Other physical effects
 - There other effects which may broaden a peak



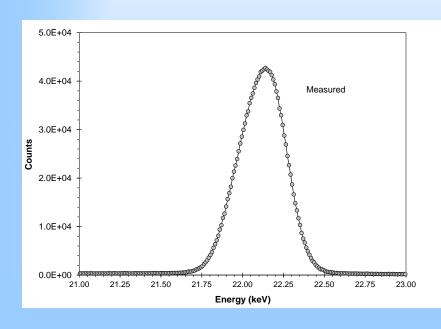


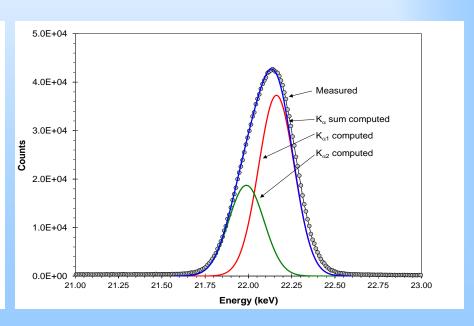


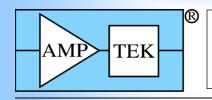
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What else contributes to photopeak shape & FWHM?

- Peak splitting
 - Not really part of the detector response but affects what you see
 - What we call a "single peak", e.g. K_{α} line, really has multiple lines ($K_{\alpha 1}$ and $K_{\alpha 2}$)
 - When the detector resolution is good enough, this splitting affect peak shape
 - Example below shows Ag K_{α} line. Detector response is 250 eV FWHM but line splitting leads to a 310 eV wide, non-Gaussian peak



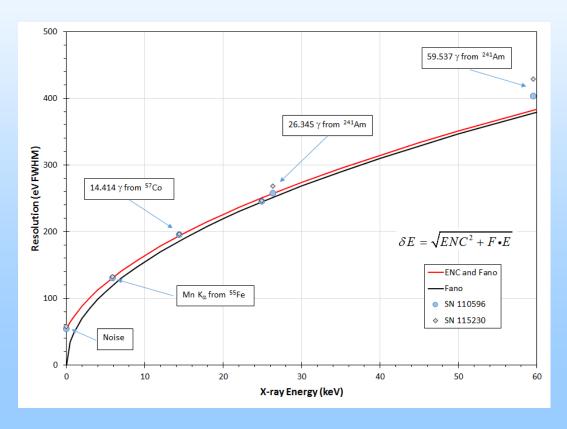


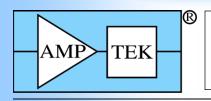


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How close is the FWHM to the theory?

- Plot below shows theoretical Fano limit (black) and combination expected from noise and Fano (red). Data points are very close
- Used monoenergetic gamma sources to avoid peak splitting

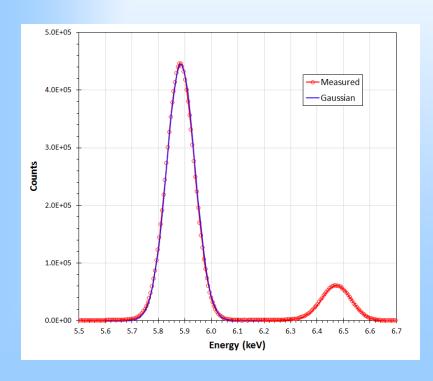


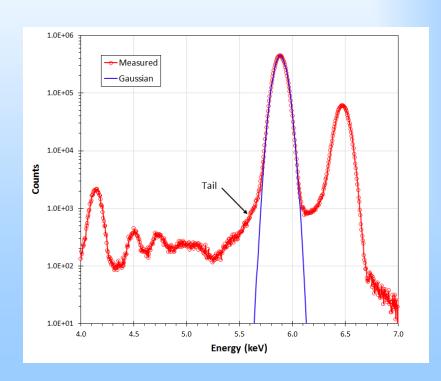


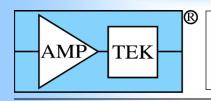
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How close is the peak shape to Gaussian?

- Plot below shows theoretical Gaussian (blue) and a measured ⁵⁵Fe spectrum (red dots)
- Deviation occurs at 0.2% of the peak



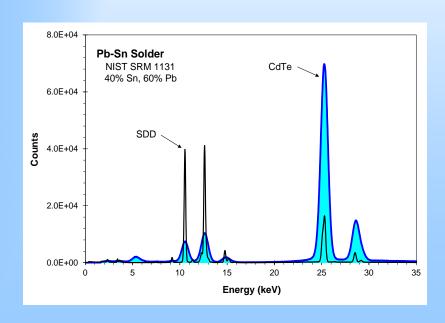


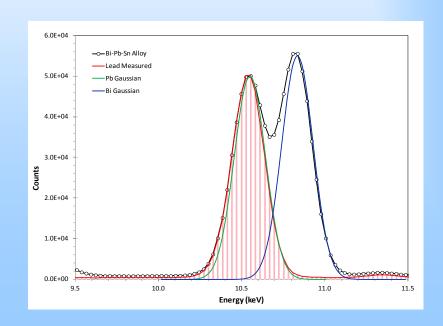


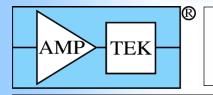
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How important is the photopeak width and shape?

- In some applications, e.g. left below, with no overlapping peaks and little background, not important at all. One can set an ROI and simply count the X-rays.
- In some applications, e.g. right below, it is VITAL. When peaks overlap, the tail of a large peak affects ability to measure adjacent weak peak.
- Deviations from the ideal shape drive the detection limit.



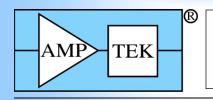




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Background

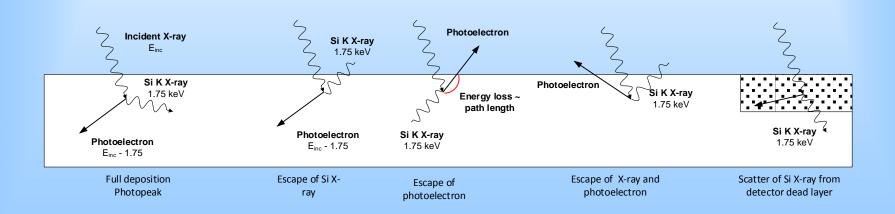
XRF Overview 10

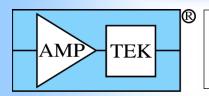


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What causes the background (1)?

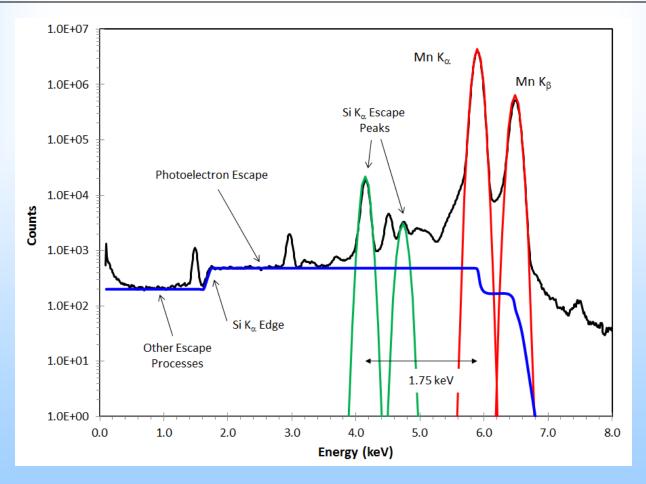
- Background includes both continuum and peaks
- X-rays scatter out of the detector active volume
 - This cannot be eliminated: due to physics of X-ray interactions
 - Continuum from escape of secondary electrons
 - Escape peaks from escape of silicon X-rays





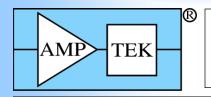
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Features in spectrum arising from physics of X-ray interaction causing X-rays or secondary electrons to scatter from the detector

XRF Overview

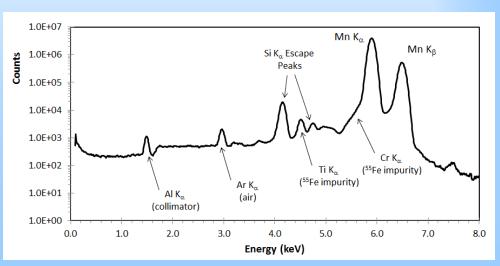


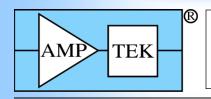
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What causes the background (2)?

- X-ray scattering from detector dead layers
 - Can be minimized with good design but never eliminated
 - Also leads to continuum and peaks
- X-ray scattering from material around the detector
 - Detector is always surrounded by stuff: housing, mount, wire bonds, capacitors, collimators, shutters, etc. These materials produce characteristic X-rays
 - Minimized with good design but cannot be eliminated

Features in spectrum due to characteristic X-ray from material near spectrometer (includes impurities in the radioactive ⁵⁵Fe)

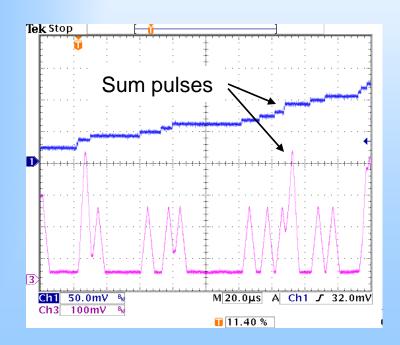


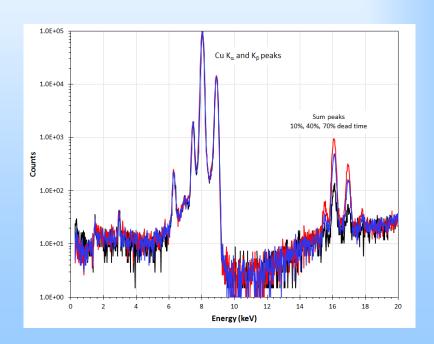


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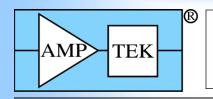
What causes the background (3)?

- Pulse pile-up
 - Occurs when two or more X-rays interact within pulse pair resolving time
 - "Sum peak" at sum of the X-ray energies. Intensity increases with count rate
 - Minimized at low count rate or short T_{peak}





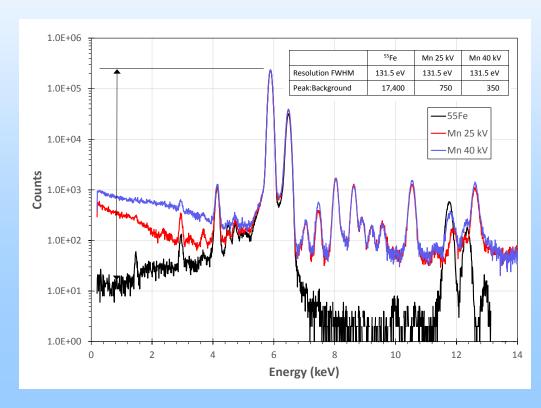
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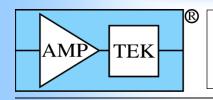
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What causes the background (4)?

- Background in the spectrum
 - Not really part of detector response but affects what you see
 - Plot below shows Mn spectrum from ⁵⁵Fe decay and X-ray excitation of Mn target
 - Same FWHM but X-ray tube produces much more background



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How important is the background?

- In some applications, where the peak intensity is strong, not important at all. One can set an ROI and apply a simple background correction
- In some applications, it is VITAL. When trying to measure small amounts, near detection limit, background features are huge.
- Plot below shows 0.5ppm Cd in a sample. Background is key

